

Notice of References Cited

Application/Control No.

10/549,480

Applicant(s)/Patent Under
Reexamination
YAMAKAWA ET AL.

Examiner

KARUNA P. REDDY

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,316,864 B2	01-2008	Nakayama et al.	429/217
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number	Date	Country	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY			
	N	WO 3036744 A1	05-2003	World Intellect	NAKAYAMA et al.	
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U				
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